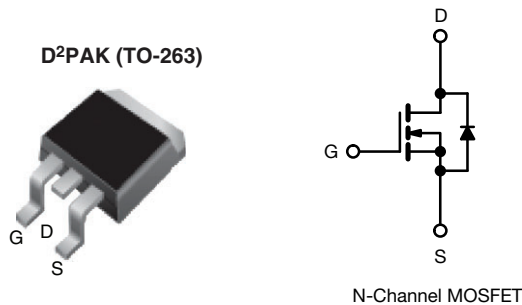


## EF Series Power MOSFET With Fast Body Diode



### FEATURES

- A specific on resistance ( $m\Omega\text{-cm}^2$ ) reduction of 25 %
- Low figure-of-merit (FOM)  $R_{\text{on}} \times Q_g$
- Low input capacitance ( $C_{\text{iss}}$ )
- Reduced switching and conduction losses
- Ultra low gate charge ( $Q_g$ )
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see [www.vishay.com/doc?99912](http://www.vishay.com/doc?99912)



**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**

### PRODUCT SUMMARY

|  |                                |       |
|--|--------------------------------|-------|
| $V_{\text{DS}}$ (V) at $T_J$ max.              | 650                            |       |
| $R_{\text{DS(on)}}$ typ. ( $\Omega$ ) at 25 °C | $V_{\text{GS}} = 10 \text{ V}$ | 0.084 |
| $Q_g$ max. (nC)                                | 134                            |       |
| $Q_{\text{gs}}$ (nC)                           | 16                             |       |
| $Q_{\text{gd}}$ (nC)                           | 48                             |       |
| Configuration                                  | Single                         |       |

### APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
  - Battery chargers
  - Renewable energy
  - Solar (PV inverters)

### ORDERING INFORMATION

|                                 |                             |
|---------------------------------|-----------------------------|
| Package                         | D <sup>2</sup> PAK (TO-263) |
| Lead (Pb)-free and halogen-free | SiHB35N60EF-GE3             |


### ABSOLUTE MAXIMUM RATINGS ( $T_C = 25 \text{ }^\circ\text{C}$ , unless otherwise noted)

| PARAMETER   | SYMBOL                  | LIMIT                              | UNIT                |   |
|---|-------------------------|------------------------------------|---------------------|---|
| Drain-source voltage  | $V_{\text{DS}}$         | 600                                | V                   |   |
| Gate-source voltage   | $V_{\text{GS}}$         | $\pm 30$                           |                     |   |
| Continuous drain current ( $T_J = 150 \text{ }^\circ\text{C}$ ) | $V_{\text{GS}}$ at 10 V | $T_C = 25 \text{ }^\circ\text{C}$  | 32                  | A |
|   |                         | $T_C = 100 \text{ }^\circ\text{C}$ | 20                  |   |
| Pulsed drain current <sup>a</sup>                               | $I_{\text{DM}}$         | 80                                 |                     |   |
| Linear derating factor  |                         | 2.0                                | W/ $^\circ\text{C}$ |   |
| Single pulse avalanche energy <sup>b</sup>                      | $E_{\text{AS}}$         | 298                                | mJ                  |   |
| Maximum power dissipation                                       | $P_{\text{D}}$          | 250                                | W                   |   |
| Operating junction and storage temperature range                | $T_J, T_{\text{stg}}$   | -55 to +150                        | $^\circ\text{C}$    |   |
| Drain-source voltage slope                                      | $dv/dt$                 | 70                                 | V/ns                |   |
| Reverse diode $dv/dt$ <sup>d</sup>                              |                         |                                    |                     |   |
| Soldering recommendations (peak temperature) <sup>c</sup>       | For 10 s                | 260                                | $^\circ\text{C}$    |   |

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature
- $V_{\text{DD}} = 140 \text{ V}$ , starting  $T_J = 25 \text{ }^\circ\text{C}$ ,  $L = 28.2 \text{ mH}$ ,  $R_g = 25 \text{ } \Omega$ ,  $I_{\text{AS}} = 4.6 \text{ A}$
- 1.6 mm from case
- $I_{\text{SD}} = 17 \text{ A}$ ,  $di/dt = 300 \text{ A}/\mu\text{s}$ , starting  $T_J = 25 \text{ }^\circ\text{C}$

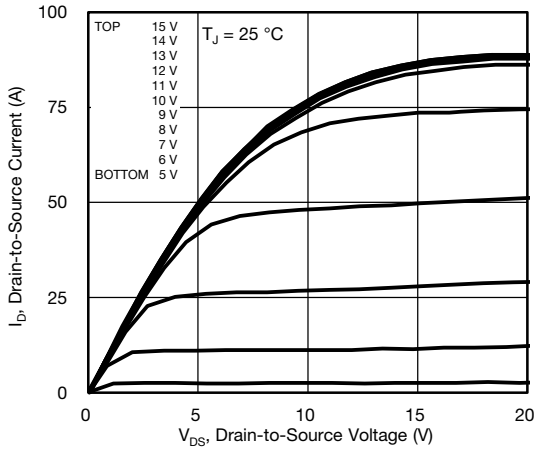
| THERMAL RESISTANCE RATINGS       |            |      |      |      |
|----------------------------------|------------|------|------|------|
| PARAMETER                        | SYMBOL     | TYP. | MAX. | UNIT |
| Maximum junction-to-ambient      | $R_{thJA}$ | -    | 62   | °C/W |
| Maximum junction-to-case (drain) | $R_{thJC}$ | -    | 0.5  |      |

| SPECIFICATIONS ( $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted) |                     |   |  |      |       |           |               |
|---|---------------------|---|--|------|-------|-----------|---------------|
| PARAMETER   | SYMBOL              | TEST CONDITIONS   |  | MIN. | TYP.  | MAX.      | UNIT          |
| <b>Static</b>   |                     |   |  |      |       |           |               |
| Drain-source breakdown voltage  | $V_{DS}$            | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$   |  | 600  | -     | -         | V             |
| $V_{DS}$ temperature coefficient  | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}$ , $I_D = 10\text{ mA}$  |  | -    | 0.66  | -         | V/°C          |
| Gate-source threshold voltage (N)   | $V_{GS(th)}$        | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$   |  | 2.0  | -     | 4.0       | V             |
| Gate-source leakage   | $I_{GSS}$           | $V_{GS} = \pm 20\text{ V}$  |  | -    | -     | $\pm 100$ | nA            |
|   |                     | $V_{GS} = \pm 30\text{ V}$  |  | -    | -     | $\pm 1$   | $\mu\text{A}$ |
| Zero gate voltage drain current   | $I_{DSS}$           | $V_{DS} = 480\text{ V}, V_{GS} = 0\text{ V}$  |  | -    | -     | 1         | $\mu\text{A}$ |
|   |                     | $V_{DS} = 480\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$   |  | -    | -     | 500       |               |
| Drain-source on-state resistance  | $R_{DS(on)}$        | $V_{GS} = 10\text{ V}$  | $I_D = 17\text{ A}$                        | -    | 0.084 | 0.097     | $\Omega$      |
| Forward transconductance <sup>a</sup>                                       | $g_{fs}$            | $V_{DS} = 30\text{ V}, I_D = 17\text{ A}$   |  | -    | 8     | -         | S             |
| <b>Dynamic</b>  |                     |   |  |      |       |           |               |
| Input capacitance   | $C_{iss}$           | $V_{GS} = 0\text{ V},$<br>$V_{DS} = 100\text{ V},$<br>$f = 1\text{ MHz}$  |  | -    | 2568  | -         | pF            |
| Output capacitance  | $C_{oss}$           |   |  | -    | 113   | -         |               |
| Reverse transfer capacitance  | $C_{rss}$           |   |  | -    | 7     | -         |               |
| Effective output capacitance, energy related <sup>a</sup>                   | $C_{o(er)}$         |   |  | -    | 81    | -         |               |
| Effective output capacitance, time related <sup>b</sup>                     | $C_{o(tr)}$         | $V_{DS} = 0\text{ V to } 480\text{ V}, V_{GS} = 0\text{ V}$   |  | -    | 421   | -         |               |
| Total gate charge   | $Q_g$               | $V_{GS} = 10\text{ V}$  | $I_D = 17\text{ A}, V_{DS} = 480\text{ V}$ | -    | 89    | 134       | nC            |
| Gate-source charge  | $Q_{gs}$            |   |  | -    | 16    | -         |               |
| Gate-drain charge   | $Q_{gd}$            |   |  | -    | 48    | -         |               |
| Turn-on delay time  | $t_{d(on)}$         | $V_{DD} = 480\text{ V}, I_D = 17\text{ A},$<br>$V_{GS} = 10\text{ V}, R_g = 9.1\text{ }\Omega$  |  | -    | 28    | 56        | ns            |
| Rise time   | $t_r$               |   |  | -    | 85    | 170       |               |
| Turn-off delay time   | $t_{d(off)}$        |   |  | -    | 96    | 192       |               |
| Fall time   | $t_f$               |   |  | -    | 61    | 122       |               |
| Gate input resistance   | $R_g$               | $f = 1\text{ MHz}, \text{ open drain}$  |  | 0.2  | 0.5   | 1.0       | $\Omega$      |
| <b>Drain-Source Body Diode Characteristics</b>                              |                     |   |  |      |       |           |               |
| Continuous source-drain diode current                                       | $I_S$               | MOSFET symbol showing the integral reverse p - n junction diode  |  | -    | -     | 32        | A             |
| Pulsed diode forward current  | $I_{SM}$            |   |  | -    | -     | 80        |               |
| Diode forward voltage   | $V_{SD}$            | $T_J = 25\text{ }^\circ\text{C}, I_S = 17\text{ A}, V_{GS} = 0\text{ V}$  |  | -    | -     | 1.2       | V             |
| Reverse recovery time   | $t_{rr}$            | $T_J = 25\text{ }^\circ\text{C}, I_F = I_S = 17\text{ A},$<br>$di/dt = 100\text{ A}/\mu\text{s}, V_R = 400\text{ V}$                                  |  | -    | 150   | 300       | ns            |
| Reverse recovery charge   | $Q_{rr}$            |   |  | -    | 1.1   | 2.2       | $\mu\text{C}$ |
| Reverse recovery current  | $I_{RRM}$           |   |  | -    | 14    | -         | A             |

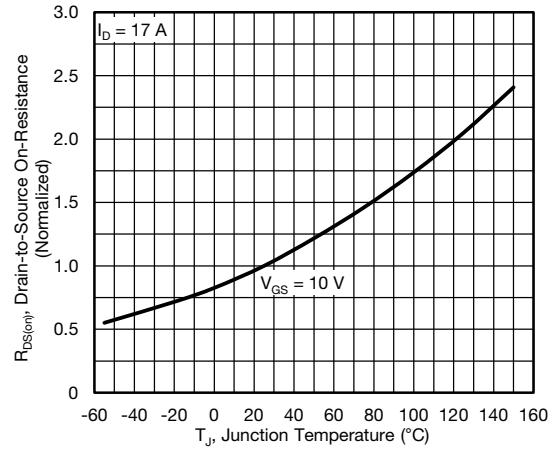
**Notes**

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$   
 b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$

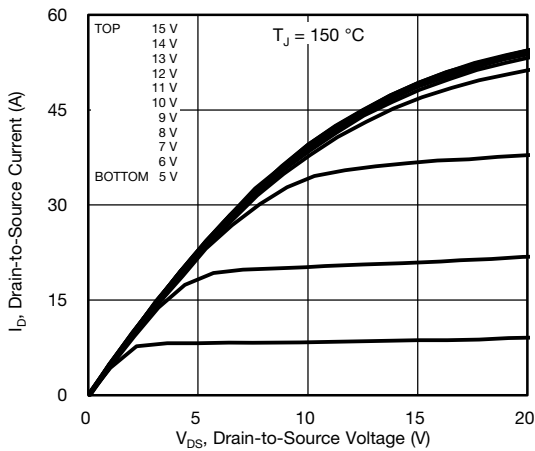
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



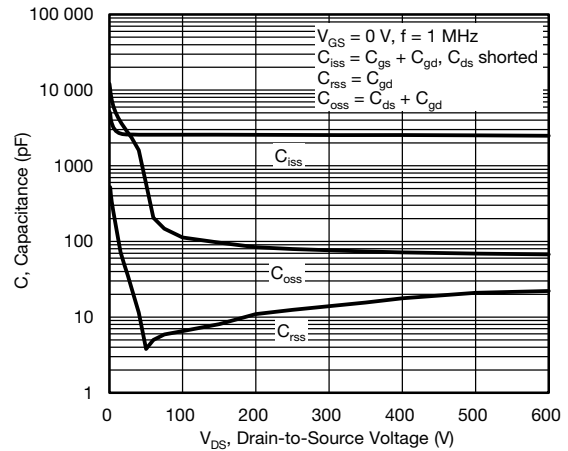
**Fig. 1 - Typical Output Characteristics**



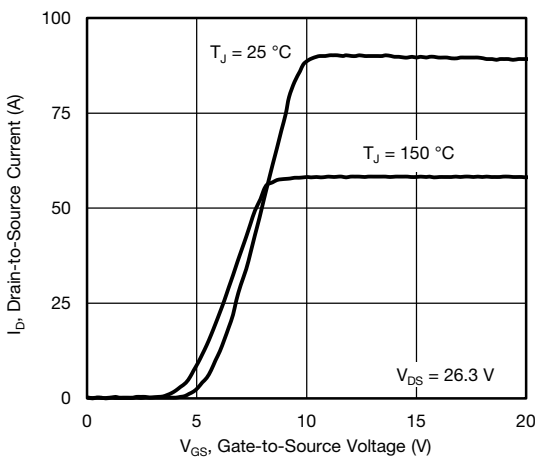
**Fig. 4 - Normalized On-Resistance vs. Temperature**



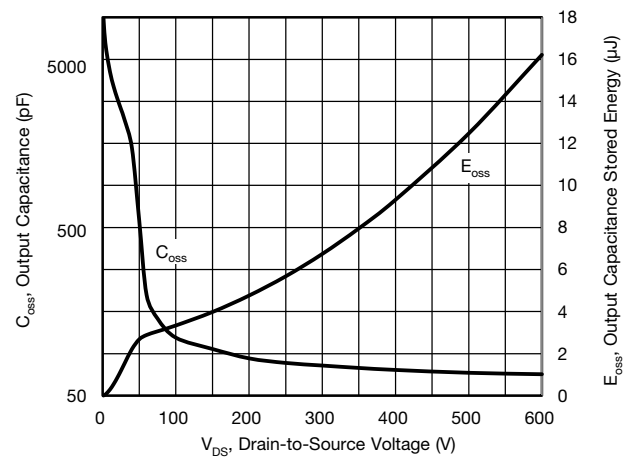
**Fig. 2 - Typical Output Characteristics**



**Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage**



**Fig. 3 - Typical Transfer Characteristics**



**Fig. 6 - C<sub>oss</sub> and E<sub>oss</sub> vs. V<sub>DS</sub>**

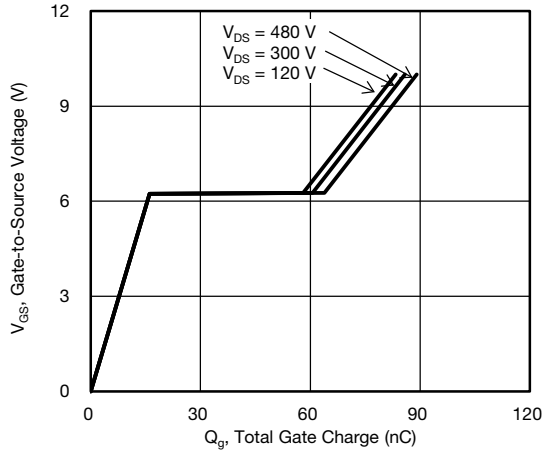


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

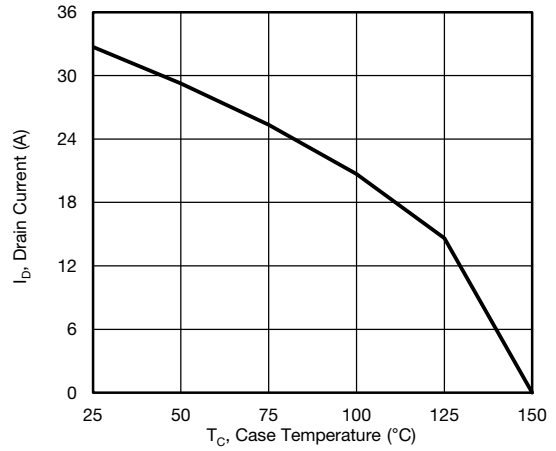


Fig. 10 - Maximum Drain Current vs. Case Temperature

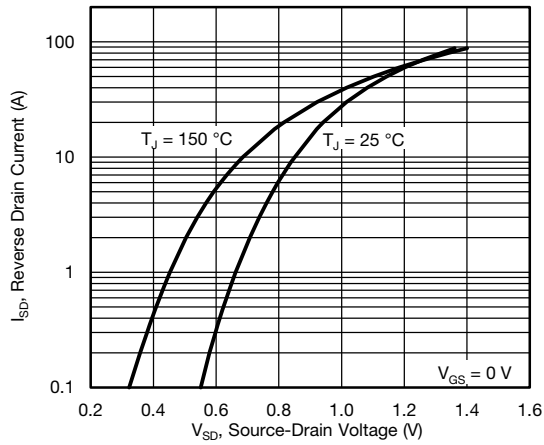


Fig. 8 - Typical Source-Drain Diode Forward Voltage

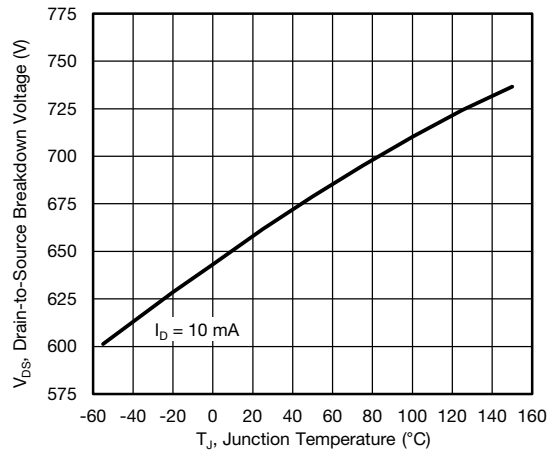


Fig. 11 - Temperature vs. Drain-to-Source Voltage

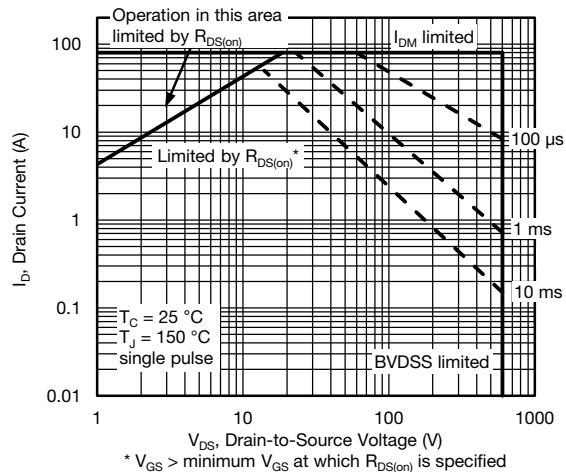


Fig. 9 - Maximum Safe Operating Area

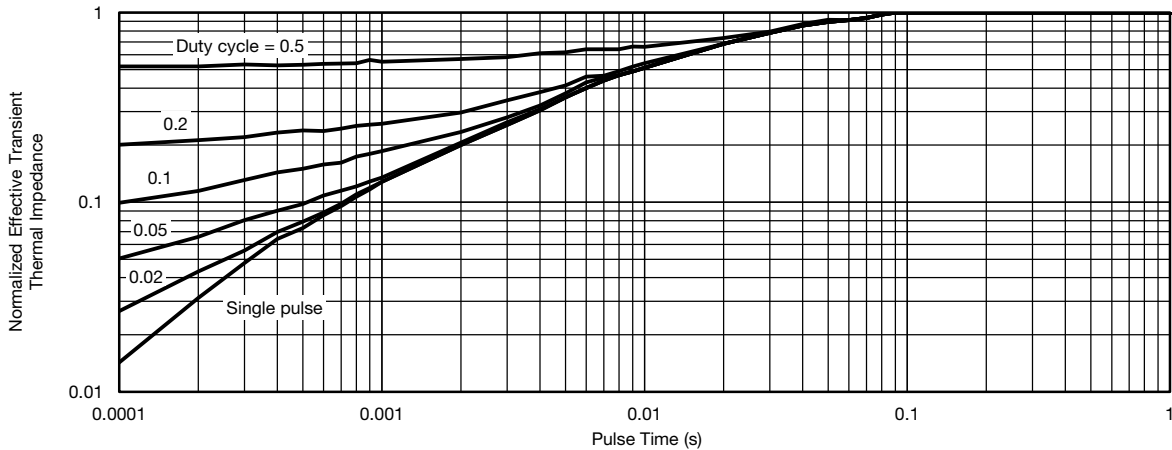


Fig. 12 - Normalized Transient Thermal Impedance, Junction-to-Case



Fig. 13 - Switching Time Test Circuit



Fig. 16 - Unclamped Inductive Waveforms



Fig. 14 - Switching Time Waveforms

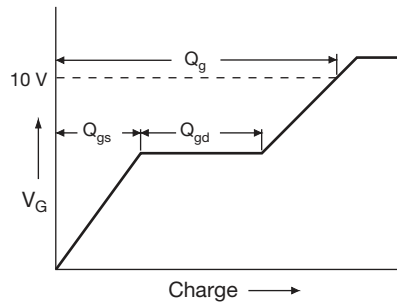


Fig. 17 - Basic Gate Charge Waveform

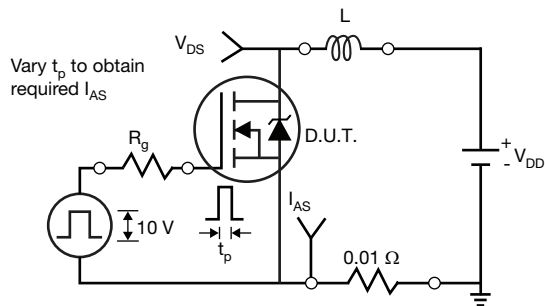


Fig. 15 - Unclamped Inductive Test Circuit



Fig. 18 - Gate Charge Test Circuit



**Note**

a.  $V_{GS} = 5 V$  for logic level devices

**Fig. 19 - For N-Channel**

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